Verification and Validation Report: Measuring Microstructure Changes During Thermal Treatment

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 $March\ 8,\ 2023$

1 Revision History

Date	Name	Notes
Mar~8~2023	Edwin Do	Added usability test results
Mar 8 2023	Edwin Do	Added Traceability matrices
Mar 8, 2023	Timothy	Added performance to the Nonfunctional
	Chen	Test Evaluation
Mar 8, 2023	Timothy	Added unit test for input communication,
	Chen	current state and remote access

2 Symbols, Abbreviations and Acronyms

change capacity to size

symbol	description
T	Test
MIN_USER_ACCEPT_RATE	90% - minimum acceptance rate
$TARGET_{-}TIME$	60 seconds
INTERACT_TIME	5 seconds
MAX_MISTAKE	2
MAX_SIZE	8GB
MIN_UPTIME	30 minutes
MIN_SAMPLE_RATE	60 samples per second
TIME_ACCEPTED	1 second
ACCEPTED_SIGFIG	3 decimals

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This document ... Section 11 Code Coverage Metrics is removed.

- 3 Functional Requirements Evaluation
- 4 Nonfunctional Requirements Evaluation

In the section

4.1 Usability

The table below shows the results of our usability tests based on the tests in the V&V plan based on the requirements mentioned in the SRS. Each requirement can be traced to multiple unit tests and the usability survey used can be found in the Appendix.

		Usability Tests		
Test Requirement	Related Unit Tests	Description	Expected Result	Result
NF-UT1	AF	Completing tasks without additional assistance.	User will be complete tasks successfully	PASS
NF-UT2	AX	Interact with interace to modify parameters.	User will be able to modify the parameters accurately and quickly.	PASS
NF-UT3	AL	Completing all tasks with limited number of mistakes	User will be able to complete all tasks with MAX_MISTAKE	PASS
NF-UT3	AL	Verifying if interacting with the application previously improves ease of use (learnability)	User will be able to complete the tasks more quickly and accurately the second time	PASS
NF-UT5	AS	Verifying how calculations are performed is hidden	User will not know how calculations are performed after doing the set of tasks	PASS
NF-UT6	AS	Verifying appropriate application size upon installation	User will install application onto computer and verify that the application size is less than or equal to MAX_SIZE	PASS

4.2 Performance

The following is the list of Non-functional Test performed on the application to evaluate the performance of the application in respect to the test requirement. Each test will be mapped to unit test that are related to the

corresponding requirement.

		Performance 7	Tests	
Test Requirement	Related Unit Tests	Description	Expected Result	Result
NF-PT1	-	Checking the minimum sampling rate of the application.	The sampling rate of the application will be equal or greater than MIN_SAMPLE_RATE	PASS
NF-PT2	-	Checking the time required for parameters to reflect in the application.	The parameters will reflect in the application by within TIME_ACCEPTED	PASS
NF-PT3	-	Checking the significant digits used for calculations and display in the application.	its seen and used in the application is accurate to AC -	PASS
NF-PT4	-	Checking the up-time of the application during and after usage.	The application will have a up-time equal to or more than MIN_UPTIME after the user completes a set of tasks.	PASS

4.3 etc.

5 Comparison to Existing Implementation

This section will not be appropriate for every project.

6 Unit Testing

6.1 Input Communication Module

	U	nit Tests for Inp	ut Communication	Module	
Unit Test ID	Description	Input	Expected Output	Output	Result
UT-IC1	Testing the ge- tUserInput Method	SamplingRate: 60, Sample-Length: 4; SampleWidth: 2; Filename: sample1; Name: Bob; Sample-Name: sample1; Date: 03/01/2023	UserInput(SamplingRate: 60; SampleLength: 4; SampleWidth: 2; Filename: sample1; Name: bob; SampleName: sample1; Date: 03/01/2023)	UserInput(SamplingRate: 60; SampleLength: 4; SampleWidth: 2; Filename: sample1; Name: bob; SampleName: sample1; Date: 03/01/2023)	PASS
UT-IC2	Testing the ge- tUserInput Method		INVALID	INVALID	PASS
UT-IC3	Testing the getHard-wareInput Method	Voltage: 5; Time: 10:00; Temperature: 50; Current: 1	HardwareInput(Voltage: 5; Time: 10:00; Temperature: 50; Current: 1)	HardwareInput(Voltage: 5; Time: 10:00; Temperature: 50; Current: 1)	PASS
UT-IC4	Testing the getHard-wareInput Method		INVALID	INVALID	PASS

6.2 Remote Access Module

	Unit Tests for Remote Access Module					
Unit Test ID	Description	Input	Expected put	Out-	Output	Result
UT- RA1	Testing the connect Method	userName: Timothy, password 12341234	Observed nected	con-		FAIL
UT- RA2	Testing the connect Method	userName: Bob, password 12341234	INVALID		INVALID	PASS
UT- RA2	Testing the connect Method	userName: Timothy, password 56785678	INVALID		INVALID	PASS
UT- RA2	Testing the connect Method	userName: Bob, password 56785678	INVALID		INVALID	PASS
UT- RA3	Testing the disconnect Method		FALSE			FAIL

6.3 Current State Module

	Unit Tests for Current State Module						
Unit Test ID	Description	Input	Expected put	Out-	Output	Result	
UT- CS1	Testing the displayUser- Info Method	SamplingRate: 60, Sample-Length: 4; SampleWidth: 2; Filename: sample1; Name: Bob; Sample-Name: sample1; Date: 03/01/2023	Observed displayed	data	data displayed	PASS	
UT- CS2	Testing the displayUser- Info Method	SamplingRate: ABC, SampleLength: 4; SampleWidth: 2; Filename: sample1; Name: Bob; Sample-Name: sample1; Date: 03/01/2023	INVALID		INVALID	PASS	
UT- CS2	Testing the displayUser- Info Method	SamplingRate: -100, SampleLength: 4; SampleWidth: 2; Filename: sample1; Name: Bob; Sample- Name: sample1; Date: 03/01/2023	INVALID		INVALID	PASS	

	Unit Tests for Current State Module					
UT- CS2	Testing the displayUser- Info Method	SamplingRate : 60, SampleLength: ABC; SampleWidth: 2; Filename: sample1; Name: Bob; SampleName: sample1; Date: 03/01/2023	INVALID	INVALID	PASS	
UT- CS2	Testing the displayUser- Info Method	SamplingRate: 60, Sample-Length: -4; SampleWidth: 2; Filename: sample1; Name: Bob; Sample-Name: sample1; Date: 03/01/2023	INVALID	INVALID	PASS	
UT- CS2	Testing the displayUser- Info Method	SamplingRate: 60, Sample-Length: 4; SampleWidth: ABC; Filename: sample1; Name: Bob; Sample-Name: sample1; Date: 03/01/2023	INVALID	INVALID	PASS	

	Unit Tests for Current State Module						
UT- CS2	Testing the displayUser- Info Method	SamplingRate : 60, Sample- Length : 4; SampleWidth : -2; Filename : sample1; Name : Bob; Sample- Name :sam- ple1; Date : 03/01/2023	INVALID	INVALID	PASS		
UT- CS3	Testing the displayHard- wareState Method	Voltage: 5; Time: 10:00; Temperature: 50; Current: 1	Observed data displayed	data displayed	PASS		
UT- CS4	Testing the displayHard- wareState Method	Voltage : ABC ; Time : 10:00; Tem- perature : 50; Current: 1	INVALID	INVALID	PASS		
UT- CS4	Testing the displayHard- wareState Method	Voltage: - 5; Time: 10:00; Temperature: 50; Current: 1	INVALID	INVALID	PASS		
UT- CS4	Testing the displayHard- wareState Method	Voltage: 5; Time: ABC; Temperature : 50; Current: 1	INVALID	INVALID	PASS		
UT- CS4	Testing the displayHard- wareState Method	Voltage : 5 ; Time : - 10:00; Tem- perature : 50; Current: 1	INVALID	INVALID	PASS		

	Unit Tests for Current State Module						
UT-	Testing	Voltage: 5;	INVALID	INVALID	PASS		
CS4	the dis-	Time: 10:00;					
	playHard-	Tempera-					
	wareState	ture : ABC;					
	Method	Current: 1					
UT-	Testing	Voltage: 5;	INVALID	INVALID	PASS		
CS4	the dis-	Time: 10:00;					
	playHard-	Temperature					
	wareState	: 50; Current:					
	Method	ABC					
UT-	Testing	Voltage: 5;	INVALID	INVALID	PASS		
CS4	the dis-	Time: 10:00;					
	playHard-	Temperature					
	wareState	: 50; Current:					
	Method	-1					

6.4 Calculation Module

	Ur	nit Tests for Calcula	ation Module		
Unit Test ID	Description	Input	Expected Output	Output	Result
UT-C1	Testing the getResistance Method	From Hard-wareInput ADT: Voltage = 5, Current = 1	5.000	5.000	PASS
UT-C1	Testing the getResistance Method	From Hard-wareInput ADT: Voltage = 4, Current = 0.6	6.667	6.667	PASS
UT-C2	Testing the getResistance Method	From Hard-wareInput ADT: Voltage = -5, Current = 1	Invalid	Invalid	PASS
UT-C2	Testing the getResistance Method	From Hard-wareInput ADT: Voltage = -4, Current = 0.6	Invalid	Invalid	PASS
UT-C3	Testing the getResistivity Method	Resistance = 3, Area = 2.5, Length = 2	3.750	3.750	PASS
UT-C3	Testing the getResistivity Method	Resistance = 2, Area = 2.8, Length = 1	5.600	5.600	PASS

7 Changes Due to Testing

8 Automated Testing

9 Trace to Requirements

Traceability Matrix to Non Functional Requirements				
Requirement	Requirement(SRS)	Test Requirement	Related Unit Tests	
Type				
Non Functional	NFR-U1	NF-UT1	U	
Non Functional	NFR-U2	NF-UT2	U	
Non Functional	NFR-U3	NF-UT3	U	
Non Functional	NFR-U4	NF-UT4	U	
Non Functional	NFR-U5	NF-UT5	U	
Non Functional	NFR-U6	NF-UT6	U	

Traceability Matrix to Functional Requirements				
Requirement	Requirement(SRS)	Test Requirement	Related Unit Tests	
Type				
Functional	FR1	FR-T1	U	
Functional	FR2	FR-T2	U	
Functional	FR3	FR-T3	U	
Functional	FR4	FR-T4	U	
Functional	FR5	FR-T5	U	
Functional	FR6	FR-T6	U	

10 Trace to Modules

References

Appendix — Reflection

The information in this section will be used to evaluate the team members on the graduate attribute of Lifelong Learning. Please answer the following questions:

- 1.
- 2.